UNISONIC TECHNOLOGIES CO., LTD

7N70-HC Power MOSFET

7A, 700V **N-CHANNEL POWER MOSFET**

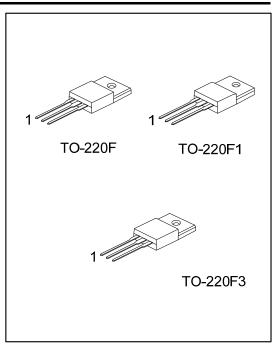
DESCRIPTION

The UTC 7N70-HC is a N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology allows a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

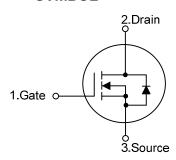
The UTC 7N70-HC is generally applied in high efficiency switch mode power supplies.

FEATURES

- * $R_{DS(ON)}$ < 1.4 Ω @ V_{GS} =10V, I_{D} =3.5A
- * Fast Switching
- * With 100% Avalanche Tested



SYMBOL



ORDERING INFORMATION

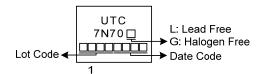
Ordering Number		Dackage	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
7N70L-TF1-T	7N70G-TF1-T	TO-220F1	G	D	S	Tube	
7N70L-TF3-T	7N70G-TF3-T	TO-220F	G	D	S	Tube	
7N70L-TF3T-T	7N70G-TF3T-T	TO-220F3	G	D	S	Tube	

Note: Pin Assignment: G: Gate S: Source D: Drain



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MARKING





7N70-HC Power MOSFET

■ ABSOLUTE MAXIMUM RATINGS (T_C =25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	700	V
Gate-Source Voltage		V_{GSS}	±30	V
Drain Current	Continuous	I _D	7	Α
	Pulsed (Note 2)	I _{DM}	14	Α
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	480	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	2.2	V/ns
Power Dissipation		P_D	40	W
Junction Temperature		T _J	+150	°C
Storage Temperature Range		T _{STG}	-55 ~ +150	°C

- Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
 - 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
 - 3. L=60mH, I_{AS} =4.0A, V_{DD} = 50V, R_{G} =25 Ω , Starting T_{J} =25 $^{\circ}$ C
 - 4. $I_{SD} \le 7.0A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25$ °C

■ THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	θ_{JA}	62.5	°C/W	
Junction to Case	$\theta_{ m JC}$	3.12	°C/W	

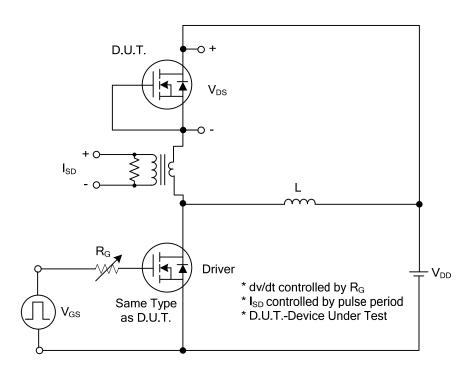
■ **ELECTRICAL CHARACTERISTICS** (T_J=25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage		BV _{DSS}	V _{GS} =0V, I _D =250μA				V	
Drain-Source Leakage Current		I _{DSS}	V _{DS} =700V, V _{GS} =0V			10	μΑ	
Gate-Source Leakage Current	rward	Lana	V_{DS} =0V , V_{GS} =30V			100	nA	
Re	verse	I _{GSS}	V_{DS} =0V , V_{GS} =-30V			-100	nA	
ON CHARACTERISTICS								
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_D = 250 \mu A$ 2.			4.0	V	
Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =3.5A			1.4	Ω	
DYNAMIC PARAMETERS								
Input Capacitance		C_{ISS}			868		pF	
Output Capacitance		Coss	V_{GS} =0V, V_{DS} =25V, f=1.0MHz		125		pF	
Reverse Transfer Capacitance		C_{RSS}			30		pF	
SWITCHING PARAMETERS								
Total Gate Charge (Note 1)		Q_G	V _{DS} =300V, V _{GS} =10V, I _D =7A ,		35		nC	
Gate to Source Charge		Q_{GS}	I_{G} =1mA (Note 1, 2)		7.4		nC	
Gate to Drain Charge		Q_GD	IG-IIIA (Note 1, 2)		12.6		nC	
Turn-ON Delay Time (Note 1)		$t_{D(ON)}$	V _{DD} =30V, V _{GS} =10V, I _D =0.5A, R _G =25Ω (Note 1, 2)		40		ns	
Rise Time		t_R			102		ns	
Turn-OFF Delay Time		$t_{D(OFF)}$			264		ns	
Fall-Time		t_{F}			172		ns	
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Maximum Body-Diode Continuous Current		I_S	10, V 0	W		7	Α	
Maximum Body-Diode Pulsed Current		I _{SM}	K Pro Co			14	Α	
Drain-Source Diode Forward Voltage (Note 1)		V_{SD}	$I_S = 7.0A, V_{GS} = 0V$			1.4	V	
Body Diode Reverse Recovery Time (Note 1)		t _{rr}	$I_S = 7.0A$, $V_{GS} = 0V$,	•	420		ns	
Body Diode Reverse Recovery Charge		Q _{rr}	dl _F /dt=100A/µs		4		μC	

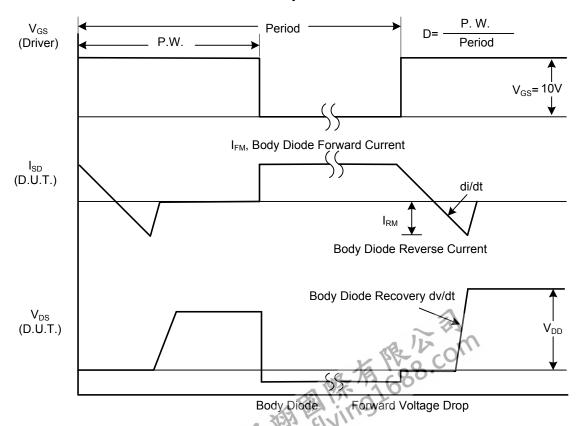
Notes: 1. Pulse Test : Pulse width ≤ 300µs, Duty cycle ≤ 2%.

2. Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS



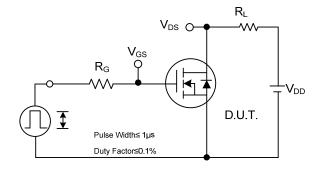
Peak Diode Recovery dv/dt Test Circuit

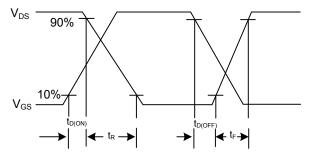


Peak Diode Recovery dv/dt Waveforms

7N70-HC **Power MOSFET**

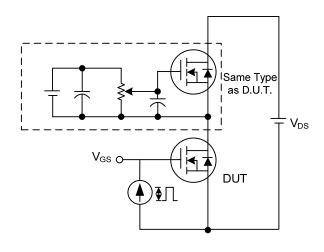
TEST CIRCUITS AND WAVEFORMS

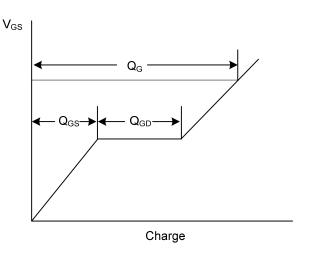




Switching Test Circuit

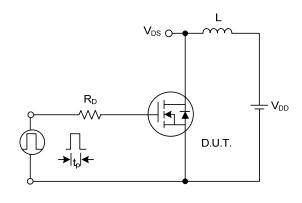
Switching Waveforms

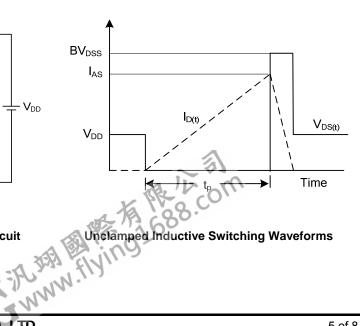




Gate Charge Test Circuit

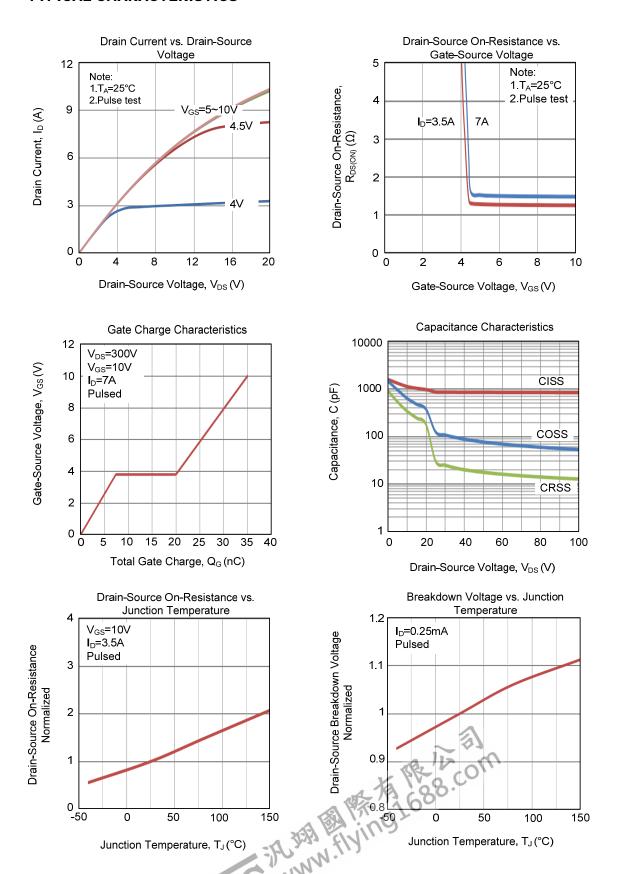
Gate Charge Waveform



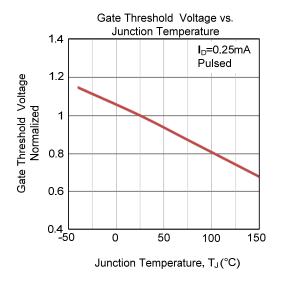


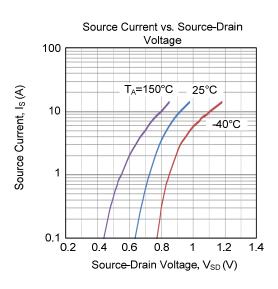
Unclamped Inductive Switching Test Circuit

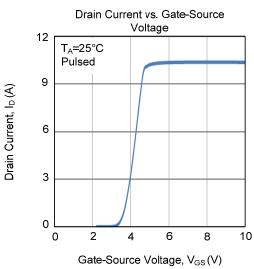
■ TYPICAL CHARACTERISTICS

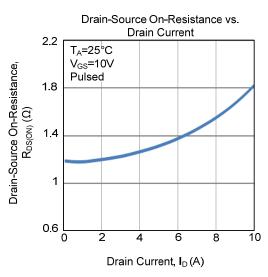


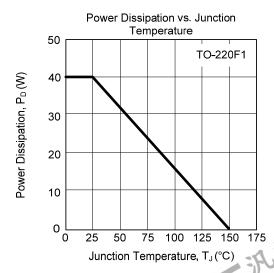
■ TYPICAL CHARACTERISTICS (Cont.)

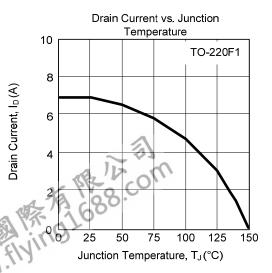




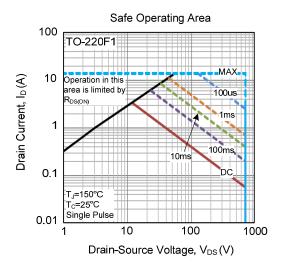








■ TYPICAL CHARACTERISTICS (Cont.)



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